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APPLICATION NO.	FILING DATE	FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO.	
09/557,088	04/21/2000	Hiroshi Sonabe	HYAE:097	6278	
75	90 09/23/2003				
Parkhurst & Wendel LLP 1421 Prince Street Suite 210			EXAMINER		
			DOOLEY, MATTHEW C		
Alexandria, VA	22314-2805		ART UNIT	PAPER NUMBER	
			2133		
			DATE MAIL ED. 00/22/2002		

Please find below and/or attached an Office communication concerning this application or proceeding.

,	Application No.		Applicant(s)	7				
Office Action Summany	09/557,088		SONABE, HIROSHI					
Office Action Summary	Examiner		Art Unit					
	Matthew C. Dooley		2133					
The MAILING DATE of this communication appears on the cover sheet with the correspondence address Period for Reply								
A SHORTENED STATUTORY PERIOD FOR REPLY IS SET TO EXPIRE 3 MONTH(S) FROM THE MAILING DATE OF THIS COMMUNICATION. - Extensions of time may be available under the provisions of 37 CFR 1.136(a). In no event, however, may a reply be timely filed after SIX (6) MONTHS from the mailing date of this communication. - If the period for reply specified above is less than thirty (30) days, a reply within the statutory minimum of thirty (30) days will be considered timely. - If NO period for reply is specified above, the maximum statutory period will apply and will expire SIX (6) MONTHS from the mailing date of this communication. - Failure to reply within the set or extended period for reply will, by statute, cause the application to become ABANDONED (35 U.S.C. § 133). - Any reply received by the Office later than three months after the mailing date of this communication, even if timely filed, may reduce any earned patent term adjustment. See 37 CFR 1.704(b). Status								
1) Responsive to communication(s) filed on 11 J	<u>uly 2003</u> .							
2a)⊠ This action is FINAL . 2b)⊡ Thi	s action is non-final.							
3) Since this application is in condition for allowance except for formal matters, prosecution as to the merits is closed in accordance with the practice under <i>Ex parte Quayle</i> , 1935 C.D. 11, 453 O.G. 213. Disposition of Claims								
4) Claim(s) 1-4 is/are pending in the application.								
4a) Of the above claim(s) is/are withdrawn from consideration.								
5) Claim(s) is/are allowed.								
6)⊠ Claim(s) <u>1-4</u> is/are rejected.								
7) Claim(s) is/are objected to.								
8) Claim(s) are subject to restriction and/or election requirement.								
Application Papers								
9) The specification is objected to by the Examiner.								
10)⊠ The drawing(s) filed on <u>21 April 2000</u> is/are: a)⊠ accepted or b)□ objected to by the Examiner.								
Applicant may not request that any objection to the drawing(s) be held in abeyance. See 37 CFR 1.85(a).								
11)☐ The proposed drawing correction filed on is: a)☐ approved b)☐ disapproved by the Examiner.								
If approved, corrected drawings are required in reply to this Office action.								
12)☐ The oath or declaration is objected to by the Exa	aminer.							
Priority under 35 U.S.C. §§ 119 and 120								
13) Acknowledgment is made of a claim for foreign	priority under 35 U.	S.C. § 119(a)	-(d) or (f).					
a)⊠ All b)□ Some * c)□ None of:								
1. Certified copies of the priority documents have been received.								
2. Certified copies of the priority documents have been received in Application No								
 3. Copies of the certified copies of the priority documents have been received in this National Stage application from the International Bureau (PCT Rule 17.2(a)). * See the attached detailed Office action for a list of the certified copies not received. 								
14) Acknowledgment is made of a claim for domestic priority under 35 U.S.C. § 119(e) (to a provisional application).								
a) ☐ The translation of the foreign language pro 15)☐ Acknowledgment is made of a claim for domesti	• •			ŕ				
Attachment(s)	, , , , , , , , , , ,	. 33 . = 9	• • •					
1) Notice of References Cited (PTO-892) 2) Notice of Draftsperson's Patent Drawing Review (PTO-948) 3) Information Disclosure Statement(s) (PTO-1449) Paper No(s)	5) 🔲 Not	ice of Informal P	(PTO-413) Paper No(s) atent Application (PTO-152)	· ·				

U.S. Patent and Trademark Office PTOL-326 (Rev. 04-01) Application/Control Number: 09/557,088

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DETAILED ACTION

Response to Amendment

Claim Rejections - 35 USC § 103

- 1. The following is a quotation of 35 U.S.C. 103(a) which forms the basis for all obviousness rejections set forth in this Office action:
 - (a) A patent may not be obtained though the invention is not identically disclosed or described as set forth in section 102 of this title, if the differences between the subject matter sought to be patented and the prior art are such that the subject matter as a whole would have been obvious at the time the invention was made to a person having ordinary skill in the art to which said subject matter pertains. Patentability shall not be negatived by the manner in which the invention was made.
- 2. Claims 1-4 are rejected under 35 U.S.C. 103(a) as being unpatentable over Endoh et al., U.S. 5,485,094, in view of Ferguson et al., U.S. 6,202,181.

As per claim 1:

Endoh teaches to a semiconductor inspection method that includes obtaining input logical values from the logical circuit such that the extracted data representing the adjacent lines have complimentary logical values (Fig.1: 10, 11: P3), as well as monitoring the output of a logical circuit that receives the input values and comparing the monitored output values with a set of expected data values (Fig.3: 35) for determination of short circuit occurrences between device lines (Col.1: 62-67). However, not explicitly taught by Endoh is that the data representing specific lines of a logical circuit of a semiconductor apparatus represented by layout data should be extracted from the tested devices for avoiding a short circuit, wherein the aforementioned lines are adjacent to one another. Ferguson teaches to a method of short circuit and stuck at fault determination in semiconductor circuit testing wherein data is extracted representing adjacent lines of a logical circuit of a semiconductor apparatus represented by layout data for testing

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purposes (Col. 10: 17-24; 45-47). It would have been obvious for one of ordinary skill in the art at the time of the invention to make use of the method of adjacent line testing taught by Ferguson with the testing method of Endoh because the method of Ferguson allows for fewer lines to have to be tested, thus leading to faster device testing (Col. 10: 23-24). Endoh clearly and particularly demonstrates motivation for rapid testing and minimum pattern selection in the testing methodology (Col. 1: 62-67), and thus, one skilled in the art would be motivated to combine the testing methodologies of the aforementioned references for faster circuit testing.

As per claim 2:

Claim 2 is similar in scope to that of claim 1, with the additional limitation of the extraction of data lines must be made when the distance between the lines is equal to or less than a threshold. Ferguson teaches to this additional limitation (Col. 10: 21-24). The remaining limitations are rejected using analogous reasoning to that used in the rejection of claim 1 above.

As per claim 3:

Claim 3 is analogous to claim 1 and as such, is rejected using analogous reasoning to that used in the rejection of claim 1 above.

As per claim 4:

Claim 4 is analogous in scope to claim 2 and as such, is rejected using analogous reasoning to that used in the rejection of claim 1 above.

Conclusion

3. Applicant's amendment necessitated the new ground(s) of rejection presented in this Office action. Accordingly, **THIS ACTION IS MADE FINAL**. See MPEP § 706.07(a). Applicant is reminded of the extension of time policy as set forth in 37 CFR 1.136(a).

A shortened statutory period for reply to this final action is set to expire THREE MONTHS from the mailing date of this action. In the event a first reply is filed within TWO MONTHS of the mailing date of this final action and the advisory action is not mailed until after the end of the THREE-MONTH shortened statutory period, then the shortened statutory period will expire on the date the advisory action is mailed, and any extension fee pursuant to 37 CFR 1.136(a) will be calculated from the mailing date of the advisory action. In no event, however, will the statutory period for reply expire later than SIX MONTHS from the date of this final action.

4. Any inquiry concerning this communication or earlier communications from the examiner should be directed to Matthew C. Dooley whose telephone number is (703) 306-5538. The examiner can normally be reached on M-F 8:30-5:00.

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Albert Decady can be reached on (703) 305-9595. The fax phone number for the organization where this application or proceeding is assigned is (703) 872-9306.

Any inquiry of a general nature or relating to the status of this application or proceeding should be directed to the receptionist whose telephone number is (703) 305-3900.

Matthew Dooley Examiner AU 2133

09/08/2003

SUPERVISORY PATENT EXAMINATION

TECHNOLOGY CENTER -